

<b>Notice of References Cited</b>	Application/Control No. 10/608,304		Applicant(s)/Patent Under Reexamination CORMIER ET AL.	
	Examiner James H. Alstrum-Acevedo		Art Unit 1616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,505,890	03-1985	Jain et al.	424/480
*	B	US-2002/0012741	01-2002	Heinz et al.	427/2.1
*	C	US-6,294,515	09-2001	Baum, Burton M.	510/514
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Dominguez et al. "Determination of Critical Micelle Concentration of Some Surfactants by Three Techniques," J. Chem. Educ. 1997, 74(10), 1227 (Abstract).
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.